


<b>Search Notes</b>  	<b>Application/Control No.</b>  10783472	<b>Applicant(s)/Patent Under Reexamination</b>  BASHAN ET AL.
	<b>Examiner</b>  John Pezzlo	<b>Art Unit</b>  2465

SEARCHED			
Class	Subclass	Date	Examiner
370	486	07/23/2007	KT
370	431	07/23/2007	KT
370	230, 235, 386, 486, 462	7/23/10	JP

SEARCH NOTES			
Search Notes		Date	Examiner
See EAST Search History		07/23/07	KT
Consult with Benny Tieu, SPE of Lab 7		7/25/2007	KT
Refer to EAST search		7/23/10	JP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
370	230, 235, 386, 486, 462	7/23/10	JP

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